

**Search Notes**

Application/Control No.

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Examiner

Erich A. Leeser

Applicant(s)/Patent under  
Reexamination

ANDRES-GIL ET AL.

Art Unit

1624

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
EAST 544/360, 544/374 with search terms, see printout		7/12/2007	EL

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
STN structure search	12/4/2007	EL
PALM inventor search	7/12/2007	EL
EAST 544/360, 544/374 with search terms, see printout	7/12/2007	EL